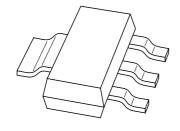
DISCRETE SEMICONDUCTORS

DATA SHEET



PBSS5350Z50 V low V_{CEsat} PNP transistor

Product data sheet Supersedes data of 2003 Jan 20 2003 May 13



50 V low V_{CEsat} PNP transistor

PBSS5350Z

FEATURES

- Low collector-emitter saturation voltage
- High collector current capability: I_C and I_{CM}
- High collector current gain (hFE) at high IC
- Higher efficiency leading to less heat generation
- Reduced PCB area requirements compared to DPAK.

APPLICATIONS

- Power management
 - DC/DC converters
 - Supply line switching
 - Battery charger
 - Linear voltage regulation (LDO).
- Peripheral drivers
 - Driver in low supply voltage applications, e.g. lamps, LFDs
 - Inductive load driver, e.g. relays, buzzers, motors.

DESCRIPTION

PNP low V_{CEsat} transistor in a SOT223 plastic package. NPN complement: PBSS4350Z.

MARKING

TYPE NUMBER	MARKING CODE
PBSS5350Z	PB5350

QUICK REFERENCE DATA

SYMBOL	PARAMETER	MAX.	UNIT
V _{CEO}	collector-emitter voltage	-50	V
I _C	collector current (DC)	-3	Α
I _{CM}	peak collector current	-5	Α
R _{CEsat}	equivalent on-resistance	<150	mΩ

PINNING

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PIN	DESCRIPTION	
1	base	
2	collector	
3	emitter	
4	collector	

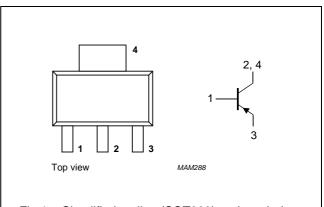


Fig.1 Simplified outline (SOT223) and symbol.

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LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{CBO}	collector-base voltage	open emitter	_	-60	V
V_{CEO}	collector-emitter voltage	open base	-	-50	V
V _{EBO}	emitter-base voltage	open collector	_	-6	V
Ic	collector current (DC)		_	-3	Α
I _{CM}	peak collector current		_	-5	Α
I _{BM}	peak base current		_	-1	Α
P _{tot}	total power dissipation	T _{amb} ≤ 25 °C; notes 1 and 3	_	1.35	W
		T _{amb} ≤ 25 °C; notes 2 and 3	_	2	W
T _{stg}	storage temperature		-65	+150	°C
Tj	junction temperature		_	150	°C
T _{amb}	operating ambient temperature		-65	+150	°C

Notes

- 1. Device mounted on a printed-circuit board; single sided copper; tinplated; mounting pad for collector 1 cm².
- 2. Device mounted on a printed-circuit board; single sided copper; tinplated; mounting pad for collector 6 cm².
- 3. For other mounting conditions see "Thermal considerations for SOT223 in the General Part of associated Handbook".

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R _{th j-a}	thermal resistance from junction to ambient	in free air; notes 1 and 3	92	K/W
		in free air; notes 2 and 3	62.5	K/W

Notes

- 1. Device mounted on a printed-circuit board; single sided copper; tinplated; mounting pad for collector 1 cm.
- 2. Device mounted on a printed-circuit board; single sided copper; tinplated; mounting pad for collector 6 cm².
- 3. For other mounting conditions see "Thermal considerations for SOT223 in the General Part of associated Handbook".

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CHARACTERISTICS

 T_{amb} = 25 °C unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
I _{CBO}	collector-base cut-off current	$V_{CB} = -50 \text{ V}; I_E = 0$	_	_	-100	nA
		$V_{CB} = -50 \text{ V}; I_E = 0; T_j = 150 \text{ °C}$	_	_	-50	μΑ
I _{EBO}	emitter-base cut-off current	$V_{EB} = -5 \text{ V}; I_C = 0$	_	_	-100	nA
h _{FE}	DC current gain	V _{CE} = −2 V;				
		$I_{C} = -500 \text{ mA}$	200	_	_	
		$I_{C} = -1 \text{ A}$; note 1	200	_	_	
		$I_C = -2 A$; note 1	100	_	_	
V _{CEsat}	collector-emitter saturation	$I_C = -500 \text{ mA}; I_B = -50 \text{ mA}$	_	_	-100	mV
voltage	$I_C = -1 \text{ A}; I_B = -50 \text{ mA}$	_	_	-180	mV	
		$I_C = -2 \text{ A}$; $I_B = -200 \text{ mA}$; note 1	_	_	-300	mV
R _{CEsat}	equivalent on-resistance	$I_C = -2 \text{ A}$; $I_B = -200 \text{ mA}$; note 1	_	120	<150	mΩ
V _{BEsat}	base-emitter saturation voltage	$I_C = -2 \text{ A}; I_B = -200 \text{ mA}; \text{ note 1}$	_	_	-1.2	V
V _{BEon}	base-emitter turn-on voltage	$V_{CE} = -2 \text{ V}; I_{C} = -1 \text{ A}; \text{ note 1}$	_	_	-1.1	V
f _T	transition frequency	$I_C = -100 \text{ mA}; V_{CE} = -5 \text{ V};$ f = 100 MHz	100	_	_	MHz
C _c	collector capacitance	$V_{CB} = -10 \text{ V}; I_E = I_e = 0; f = 1 \text{ MHz}$	-	_	40	pF

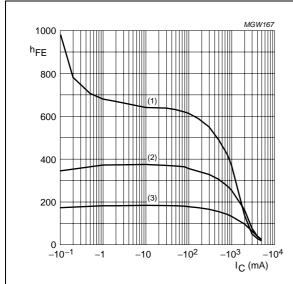
Note

1. Pulse test: $t_p \leq 300~\mu s;~\delta \leq 0.02.$

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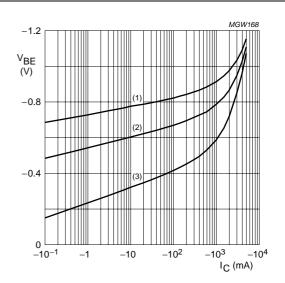
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 $V_{CE} = -2 V$.

- (1) $T_{amb} = 150 \, ^{\circ}C$.
- (2) $T_{amb} = 25 \, ^{\circ}C$.
- (3) $T_{amb} = -55 \, ^{\circ}C$.

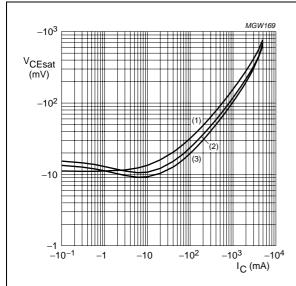
Fig.2 DC current gain as a function of collector current; typical values.



 $V_{CE} = -2 V$.

- (1) $T_{amb} = -55 \, ^{\circ}C$.
- (2) T_{amb} = 25 °C.
- (3) $T_{amb} = 150 \, ^{\circ}C$.

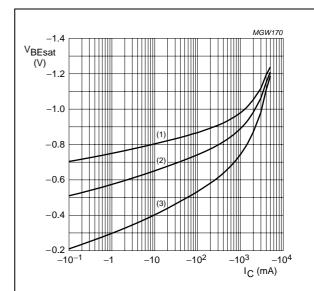
Fig.3 Base-emitter voltage as a function of collector current; typical values.



 $I_{\rm C}/I_{\rm B} = 10.$

- (1) $T_{amb} = 150 \, ^{\circ}C$.
- (2) $T_{amb} = 25 \, ^{\circ}C$.
- (3) $T_{amb} = -55 \, ^{\circ}C$.

Fig.4 Collector-emitter saturation voltage as a function of collector current; typical values.



 $I_{\rm C}/I_{\rm B} = 10.$

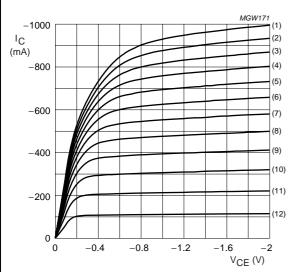
- (1) $T_{amb} = -55 \, ^{\circ}C$.
- (2) $T_{amb} = 25 \, ^{\circ}C$.
- (3) $T_{amb} = 150 \, ^{\circ}C$.

Fig.5 Base-emitter saturation voltage as a function of collector current; typical values.

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 $T_{amb} = 25 \, ^{\circ}C.$

(1) $I_B = -3.96 \text{ mA}.$

(5) $I_B = -2.64 \text{ mA}.$

(9) $I_B = -1.32 \text{ mA}.$

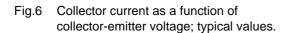
(2) $I_B = -3.63 \text{ mA}.$

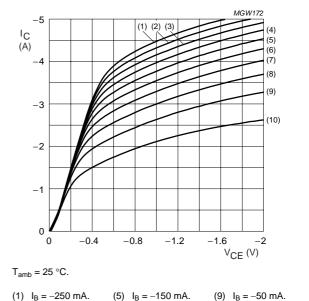
(6) $I_B = -2.31 \text{ mA}.$ (7) $I_B = -1.98 \text{ mA}.$ (10) $I_B = -0.99 \text{ mA}$. (11) $I_B = -0.66$ mA.

(3) $I_B = -3.30 \text{ mA}.$ (4) $I_B = -2.97 \text{ mA}.$

(8) $I_B = -1.65 \text{ mA}.$

(12) $I_B = -0.33$ mA.





(5) $I_B = -150 \text{ mA}$.

(9) $I_B = -50 \text{ mA}.$

(2) $I_B = -225 \text{ mA}.$

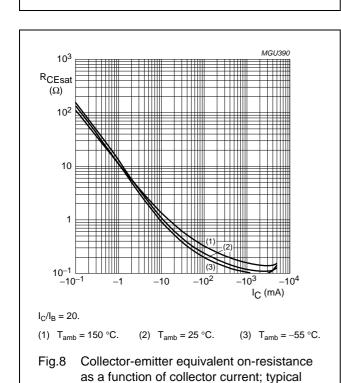
(6) $I_B = -125 \text{ mA}.$ (7) $I_B = -100 \text{ mA}.$

(10) $I_B = -25 \text{ mA}$.

(3) $I_B = -200 \text{ mA}.$ (4) $I_B = -175 \text{ mA}.$

(8) $I_B = -75 \text{ mA}.$

Collector current as a function of collector-emitter voltage; typical values.



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values.

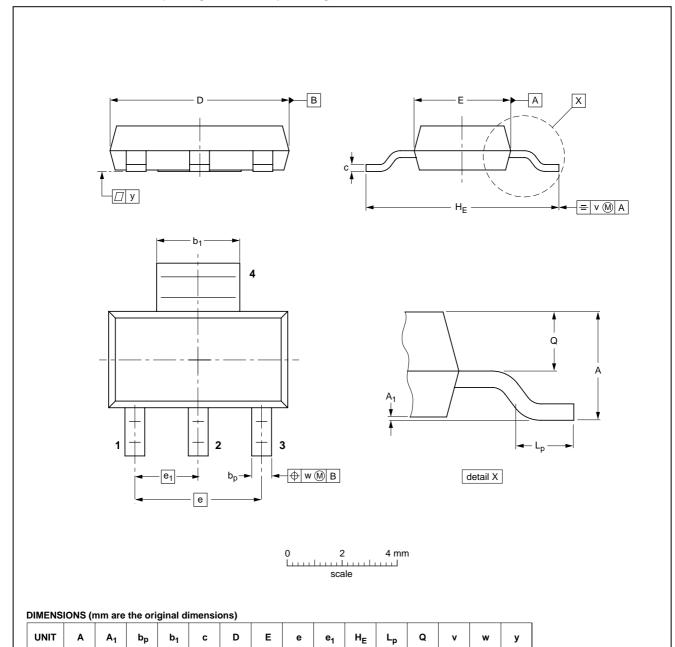
50 V low V_{CEsat} PNP transistor

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PACKAGE OUTLINE

Plastic surface mounted package; collector pad for good heat transfer; 4 leads

SOT223



OUTLINE	REFERENCES		EUROPEAN	ISSUE DATE		
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE
SOT223			SC-73			97-02-28 99-09-13

7.3

1.1

0.95

0.85

0.2

0.1

0.1

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1.8 1.5

mm

0.80

0.60

0.10

0.01

3.1 2.9 0.32

0.22

6.7

3.7

3.3

4.6

50 V low V_{CEsat} PNP transistor

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DATA SHEET STATUS

DOCUMENT STATUS ⁽¹⁾	PRODUCT STATUS ⁽²⁾	DEFINITION
Objective data sheet	Development	This document contains data from the objective specification for product development.
Preliminary data sheet	Qualification	This document contains data from the preliminary specification.
Product data sheet	Production	This document contains the product specification.

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